Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
	DESCHAMPS ET AL.	
Examiner	Art Unit	
EDMUND H. LEE	1732	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
264	115,140	4/18/2007	EHL	
	913,915			
	125,122	\downarrow	V	
264/DIG	32,325			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	4/18/2007	EHL		
INVENTOR				
264/115,140913,915,DIG 32,125,122,325				
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